

Description

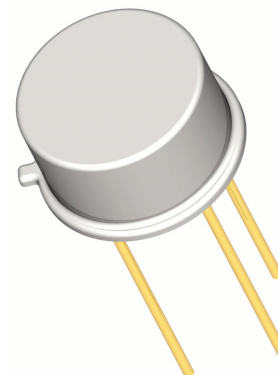
SEMICOA Corporation offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N5153LJ)
- JANTX level (2N5153LJX)
- JANTXV level (2N5153LJV)
- JANS level (2N5153LJS)
- JANSR level (2N5153LJSR)
- JANSF level (2N5153LJSF)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV and JANS
- Radiation testing (total dose) upon request

Please contact SEMICOA for special configurations
www.**SEMICOA**.com or (714) 979-1900

Applications

- High-speed power switching
- Low power
- PNP silicon transistor



Features

- Hermetically sealed TO-5 metal can
- Also available in chip configuration
- Chip geometry 9702
- Reference document: MIL-PRF-19500/545

Benefits

- Qualification Levels: JAN, JANTX, JANTXV, JANS, JANSR and JANSF
- Radiation testing available

Absolute Maximum Ratings		$T_C = 25^{\circ}\text{C}$ unless otherwise specified	
Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	80	Volts
Collector-Base Voltage	V_{CBO}	100	Volts
Emitter-Base Voltage	V_{EBO}	5.5	Volts
Collector Current, Continuous	I_C	2	A
Power Dissipation, $T_A = 25^{\circ}\text{C}$ Derate linearly above 25°C	P_T	1 5.7	W mW/ $^{\circ}\text{C}$
Power Dissipation, $T_C = 25^{\circ}\text{C}$ Derate linearly above 25°C	P_T	11.8 66.7	W mW/ $^{\circ}\text{C}$
Thermal Resistance	$R_{\theta JA}$ $R_{\theta JC}$	175 15	$^{\circ}\text{C}/\text{W}$
Operating Junction Temperature	T_J	-65 to +200	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-65 to +200	

ELECTRICAL CHARACTERISTICS

characteristics specified at $T_A = 25^\circ\text{C}$

Off Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	$I_C = 100\text{ mA}$	80			Volts
Collector-Emitter Cutoff Current	I_{CES1}	$V_{CE} = 60\text{ Volts}$			1	μA
Collector-Emitter Cutoff Current	I_{CES2}	$V_{CE} = 100\text{ Volts}$			1	mA
Collector-Emitter Cutoff Current	I_{CEO}	$V_{CE} = 40\text{ Volts}$			50	μA
Collector-Emitter Cutoff Current	I_{CEX}	$V_{CE} = 60\text{ Volts}$, $V_{EB} = 2\text{ Volts}$, $T_A = 150^\circ\text{C}$			500	nA
Emitter-Base Cutoff Current	I_{EBO1}	$V_{EB} = 4\text{ Volts}$			1	μA
Emitter-Base Cutoff Current	I_{EBO1}	$V_{EB} = 5.5\text{ Volts}$			1	mA

On Characteristics

Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	h_{FE1}	$I_C = 50\text{ mA}$, $V_{CE} = 5\text{ Volts}$	50		200	
	h_{FE2}	$I_C = 2.5\text{ A}$, $V_{CE} = 5\text{ Volts}$	70			
	h_{FE3}	$I_C = 5\text{ A}$, $V_{CE} = 5\text{ Volts}$	40			
	h_{FE4}	$I_C = 2.5\text{ A}$, $V_{CE} = 5\text{ Volts}$ $T_A = -55^\circ\text{C}$	25			
Base-Emitter Voltage	V_{BE}	$V_{CE} = 5\text{ Volts}$, $I_C = 2.5\text{ mA}$			1.45	Volts
Base-Emitter Saturation Voltage	V_{BEsat1}	$I_C = 2.5\text{ A}$, $I_B = 250\text{ mA}$			1.45	Volts
	V_{BEsat2}	$I_C = 5\text{ A}$, $I_B = 500\text{ mA}$			2.20	
Collector-Emitter Saturation Voltage	V_{CEsat1}	$I_C = 2.5\text{ A}$, $I_B = 250\text{ mA}$			0.75	Volts
	V_{CEsat2}	$I_C = 5\text{ A}$, $I_B = 500\text{ mA}$			1.50	

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{FE} $	$V_{CE} = 5\text{ Volts}$, $I_C = 500\text{ mA}$, $f = 10\text{ MHz}$	7			
Small Signal Short Circuit Forward Current Transfer Ratio	h_{FE}	$V_{CE} = 5\text{ Volts}$, $I_C = 100\text{ mA}$, $f = 1\text{ kHz}$	50			
Open Circuit Output Capacitance	C_{OBO}	$V_{CB} = 10\text{ Volts}$, $I_E = 0\text{ mA}$, $f = 1\text{ MHz}$			250	pF

Switching Characteristics

Saturated Turn-On Time	t_{ON}	$I_C = 5\text{ A}$, $I_{B1} = 500\text{ mA}$,			0.5	μs
Storage Time	t_s	$I_{B2} = -500\text{ mA}$, $V_{BEoff} = 3.7\text{ V}$,			1.4	μs
Fall Time	t_f	$R_L = 6\ \Omega$			0.5	μs
Saturated Turn-Off Time	t_{OFF}				1.5	μs